

RoHS

COMPLIANT

# NCEP60T12A-VB Datasheet N-Channel 60 V (D-S) MOSFET

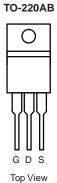
| PRODUCT SUMMARY                           |        |  |  |  |  |
|---|--------|--|--|--|--|
| V <sub>DS</sub> (V)                       | 60     |  |  |  |  |
| $R_{DS(on)} (\Omega)$ at $V_{GS} = 10 V$  | 0.003  |  |  |  |  |
| $R_{DS(on)} (\Omega)$ at $V_{GS} = 4.5 V$ | 0.009  |  |  |  |  |
| I <sub>D</sub> (A)                        | 210    |  |  |  |  |
| Configuration                             | Single |  |  |  |  |

#### FEATURES

- Halogen-free According to IEC 61249-2-21
  Definition
- Trench Power MOSFET
- Package with Low Thermal Resistance
- 100 % R<sub>g</sub> and UIS Tested

D

• Compliant to RoHS Directive 2002/95/EC





N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS (                                | T <sub>C</sub> = 25 °C, unles | s otherwise notec                 | ł)               |      |
|---|-------------------------------|-----------------------------------|------------------|------|
| PARAMETER   |                               | SYMBOL                            | LIMIT            | UNIT |
| Drain-Source Voltage                                      |                               | V <sub>DS</sub>                   | 60               | v    |
| Gate-Source Voltage                                       |                               | V <sub>GS</sub>                   | ± 20             | v    |
| Continuous Durin Comment                                  | T <sub>C</sub> = 25 °C        |                                   | 210              |      |
| Continuous Drain Current                                  | T <sub>C</sub> = 125 °C       | I <sub>D</sub>                    | 120 <sup>a</sup> |      |
| Continuous Source Current (Diode Conduction) <sup>a</sup> |                               | I <sub>S</sub>                    | 120 <sup>a</sup> | А    |
| Pulsed Drain Current <sup>b</sup>                         |                               | I <sub>DM</sub>                   | 480              |      |
| Single Pulse Avalanche Current                            | 1 0.1 mll                     | I <sub>AS</sub>                   | 75               |      |
| Single Pulse Avalanche Energy                             | L = 0.1 mH                    | E <sub>AS</sub>                   | 281              | mJ   |
| Mauianan Davian Diasia atian b                            | T <sub>C</sub> = 25 °C        | PD                                | 375              | 14/  |
| Maximum Power Dissipation <sup>b</sup>                    | T <sub>C</sub> = 125 °C       |                                   | 125              | W    |
| Operating Junction and Storage Temperature R              | ange                          | T <sub>J</sub> , T <sub>stg</sub> | - 55 to + 175    | °C   |

| THERMAL RESISTANCE RATINGS |                        |                   |       |      |
|----------------------------|------------------------|-------------------|-------|------|
| PARAMETER                  |                        | SYMBOL            | LIMIT | UNIT |
| Junction-to-Ambient        | PCB Mount <sup>c</sup> | R <sub>thJA</sub> | 40    | °C/W |
| Junction-to-Case (Drain)   |                        | R <sub>thJC</sub> | 0.4   | C/W  |

#### Notes

a. Package limited.

b. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%.$ 

c. When mounted on 1" square PCB (FR-4 material).

d. Parametric verification ongoing.

| PARAMETER                                     | SYMBOL                   | TEST CONDITIONS   |   | MIN. | TYP.  | MAX.  | UNIT |  |
|---|--------------------------|---|---|------|-------|-------|------|--|
| Static  |                          |   |   |      |       |       |      |  |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>          | $V_{GS} = 0, I_D = 250 \ \mu A$   |   | 60   | -     | -     | v    |  |
| Gate-Source Threshold Voltage                 | V <sub>GS(th)</sub>      | V <sub>DS</sub> =   | = V <sub>GS</sub> , I <sub>D</sub> = 250 μA                   | 2.0  | -     | 3.5   | V    |  |
| Gate-Source Leakage                           | I <sub>GSS</sub>         | V <sub>DS</sub> =   | 0 V, $V_{GS}$ = ± 20 V  | -    | -     | ± 100 | nA   |  |
|   |                          | $V_{GS} = 0 V$  | V <sub>DS</sub> = 60 V  | -    | -     | 1.0   |      |  |
| Zero Gate Voltage Drain Current               | I <sub>DSS</sub>         | $V_{GS} = 0 V$  | $V_{DS} = 60 \text{ V}, \text{ T}_{J} = 125 ^{\circ}\text{C}$ | -    | -     | 50    | μA   |  |
|   |                          | $V_{GS} = 0 V$  | V <sub>DS</sub> = 60 V, T <sub>J</sub> = 175 °C               | -    | -     | 350   |      |  |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>       | V <sub>GS</sub> = 10 V  | $V_{DS} \ge 5 V$  | 120  | -     | -     | Α    |  |
|   |                          | V <sub>GS</sub> = 10 V  | I <sub>D</sub> = 30 A   | -    | 0.003 | -     | Ω    |  |
| Drain Course On State Desistence?             | P                        | V <sub>GS</sub> = 10 V  | I <sub>D</sub> = 30 A, T <sub>J</sub> = 125 °C                | -    | 0.006 | -     |      |  |
| Drain-Source On-State Resistance <sup>a</sup> | R <sub>DS(on)</sub>      | $V_{GS} = 10 V$   | I <sub>D</sub> = 30 A, T <sub>J</sub> = 175 °C                | -    | 0.008 | -     |      |  |
|   |                          | V <sub>GS</sub> = 4.5 V   | I <sub>D</sub> = 20 A   | -    | 0.009 | -     |      |  |
| Forward Transconductanceb                     | 9 <sub>fs</sub>          | V <sub>DS</sub>   | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 30 A                 |      | 109   | -     | S    |  |
| Dynamic <sup>b</sup>                          | •                        | ·   |   |      |       |       |      |  |
| Input Capacitance                             | C <sub>iss</sub>         |   | V <sub>DS</sub> = 25 V, f = 1 MHz                             | -    | 9300  | -     | pF   |  |
| Output Capacitance                            | C <sub>oss</sub>         | $V_{GS} = 0 V$  |   | -    | 1000  | -     |      |  |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>         | 1   |   | -    | 750   | -     |      |  |
| Total Gate Charge <sup>c</sup>                | Qg                       |   |   | -    | 180   | -     |      |  |
| Gate-Source Charge <sup>c</sup>               | Q <sub>gs</sub>          | V <sub>GS</sub> = 10 V  | $V_{DS} = 30 \text{ V}, \text{ I}_{D} = 110 \text{ A}$        | -    | 24.7  | -     | nC   |  |
| Gate-Drain Charge <sup>c</sup>                | Q <sub>gd</sub>          | 1   |   | -    | 50.4  | -     |      |  |
| Gate Resistance                               | Rg                       | f = 1 MHz   |   | 0.5  | 1.1   | 1.6   | Ω    |  |
| Turn-On Delay Time <sup>c</sup>               | t <sub>d(on)</sub>       |   |   | -    | 19    | 29    |      |  |
| Rise Time <sup>c</sup>                        | t <sub>r</sub>           | $\label{eq:VDD} \begin{array}{l} V_{DD} = 30 \text{ V}, \text{ R}_L = 0.27 \ \Omega \\ \text{I}_D \cong 110 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_g = 2.5 \ \Omega \end{array}$ |   | -    | 23    | 35    | ns   |  |
| Turn-Off Delay Time <sup>c</sup>              | t <sub>d(off)</sub>      |   |   | -    | 83    | 125   |      |  |
| Fall Time <sup>c</sup>                        | t <sub>f</sub>           |   |   | -    | 35    | 53    |      |  |
| Source-Drain Diode Ratings and Char           | acteristics <sup>b</sup> |   |   |      |       |       |      |  |
| Pulsed Current <sup>a</sup>                   | I <sub>SM</sub>          |   |   | -    | -     | 480   | А    |  |
| Forward Voltage                               | V <sub>SD</sub>          | $I_{\rm F} = 100  \rm A,  V_{\rm GS} = 0$   |   | -    | 0.9   | 1.5   | V    |  |

Notes

a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

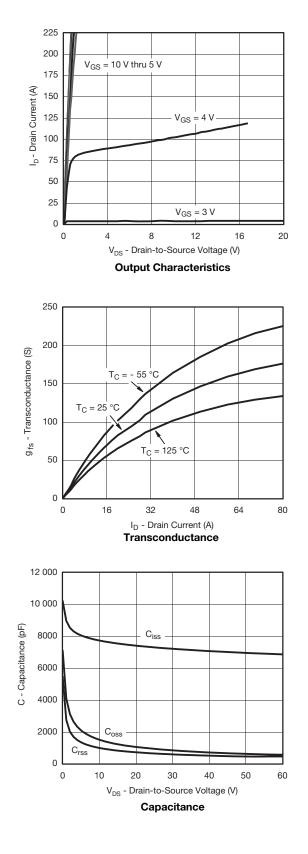
c. Independent of operating temperature.

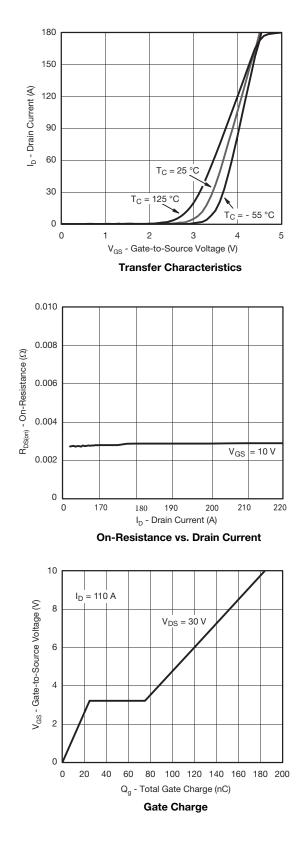
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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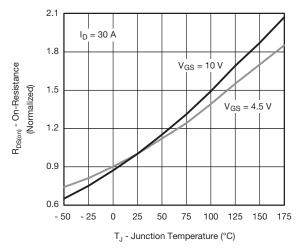
## **TYPICAL CHARACTERISTICS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)



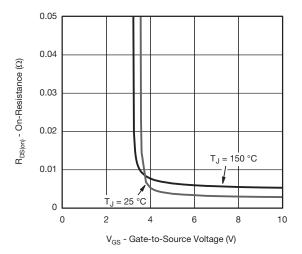




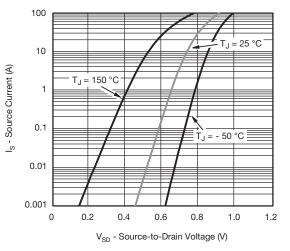
## **TYPICAL CHARACTERISTICS** (T<sub>A</sub> = 25 °C, unless otherwise noted)



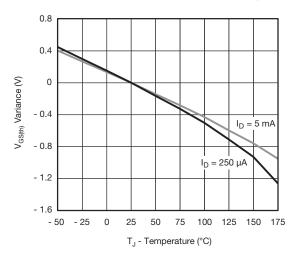




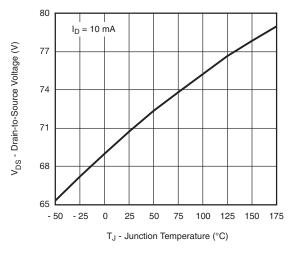
**On-Resistance vs. Gate-to-Source Voltage** 



Source Drain Diode Forward Voltage



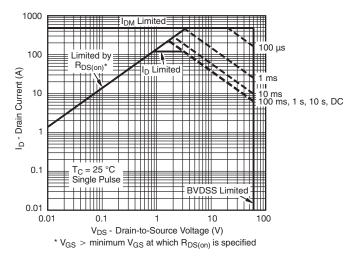
**Threshold Voltage** 



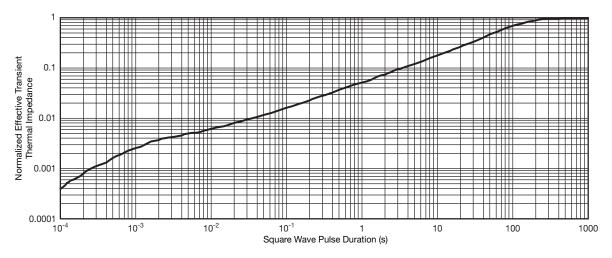
Drain Source Breakdown vs. Junction Temperature



### **THERMAL RATINGS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)



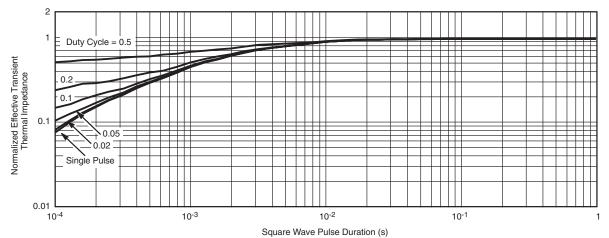
Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient



### **THERMAL RATINGS** ( $T_A = 25 \text{ °C}$ , unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

#### Note

• The characteristics shown in the two graphs

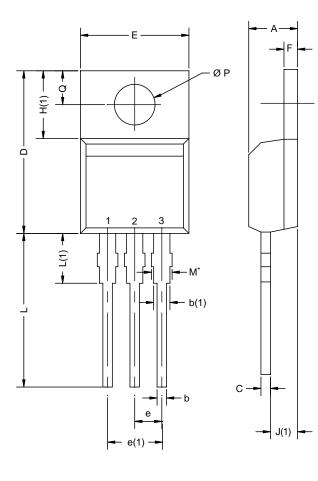
- Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)

- Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



# **TO-220AB**



|                        | MILLIMETERS       |           | INC   | CHES  |  |
|------------------------|-------------------|-----------|-------|-------|--|
| DIM.                   | MIN.              | MAX.      | MIN.  | MAX.  |  |
| А                      | 4.25              | 4.65      | 0.167 | 0.183 |  |
| b                      | 0.69              | 1.01      | 0.027 | 0.040 |  |
| b(1)                   | 1.20              | 1.73      | 0.047 | 0.068 |  |
| С                      | 0.36              | 0.61      | 0.014 | 0.024 |  |
| D                      | 14.85             | 15.49     | 0.585 | 0.610 |  |
| E                      | 10.04             | 10.51     | 0.395 | 0.414 |  |
| е                      | 2.41              | 2.67      | 0.095 | 0.105 |  |
| e(1)                   | 4.88              | 5.28      | 0.192 | 0.208 |  |
| F                      | 1.14              | 1.40      | 0.045 | 0.055 |  |
| H(1)                   | 6.09              | 6.48      | 0.240 | 0.255 |  |
| J(1)                   | 2.41              | 2.92      | 0.095 | 0.115 |  |
| L                      | 13.35             | 14.02     | 0.526 | 0.552 |  |
| L(1)                   | 3.32              | 3.82      | 0.131 | 0.150 |  |
| ØΡ                     | 3.54              | 3.94      | 0.139 | 0.155 |  |
| Q                      | 2.60              | 3.00      | 0.102 | 0.118 |  |
| ECN: X12-0<br>DWG: 547 | 0208-Rev. N,<br>I | 08-Oct-12 |       |       |  |

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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